

Serial No.: 2008-1640

DATE: 2008/12/08

ITEM: CRYSTAL RESONATORS

DSX321G	26. 000MHz
(JAPAN)	1B326000AB0AR
(INDONESIA)	1C326000AB0AR
(THAILAND)	1N326000AB0AR

Please acknowledge receipt of this specificaiton by signing and returning a copy to us.

RECEIPT					
DATE					
RECEIVED	(signature)				
	(name)				

General Manufacturer of Quartz Devices

DAISHINKU CORP.

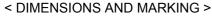
1389 Shinzaike, Hiraoka-cho, Kakogawa, Hyogo 675-0194 Japan Phone (81)79-425-3141 Fax (81)79-425-1134 http://www.kds.info/index_en.htm

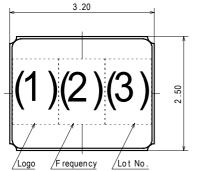
C.ENG.

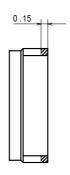
ENG.

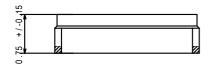
Serial No. 2008-1640

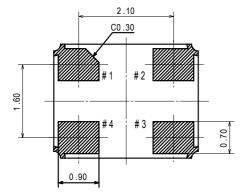
	1. ELECTRICAL CHARACTERISTICS (This test shall be performed under the conditions of temp.at 25 ± 3°C, humidity 60% max.)						
1-1	NOMINAL FREQUENCY	26.000000 MHz					
1-2	OVERTONE ORDER	Fundamental					
1-3	LOAD CAPACITANCE(CL)	19.0 pF					
1-4	FREQUENCY TOLERANCE	± 7 ppm max. at +25 °C ± 3 °C					
1-5	DRIVE LEVEL	10 ± 2 μW (100 μW max.)					
1-6	SERIES RESISTANCE	50 Ω max. / Series					
1-7	OPERATING TEMPERATURE RANGE	-40 ~ +85 °C					
1-8	FREQUENCY CHARACTERISTICS OVER TEMPERATURE	± 15 ppm max. / -40 ~ +85 °C (ref. +25°C)					
1-9	SHUNT CAPACITANCE	2.0 pF max.					
1-10	INSULATION RESISTANCE	500 M Ω min. / DC100 ± 15V					
1-11	STORAGE TEMPERATURE RANGE	-40 ~ +85 °C					
1-12	AGING	 ± 1.0 ppm max. / 1 year. ± 1.5 ppm max. / 2 years. ± 5.0 ppm max. / 10 years. 					
1-13	.PULLING SENSITIVITY	5.0 ~ 11.0 ppm / pF at CL = 19 pF (typ.)					
2. CON	STRUCTION						
2-1	HOLDER	DSX321G Ceramic Base					
2-2	DIMENSIONS AND MARKING	Refer to Fig1 and Table-1.					
3. OTH	ER SPECIFICATIONS						
3-1	EMBOSS CARRIER TAPE & REEL	Refer to Fig2,3,4,5 and Table-2.					
3-2	PACKING	Refer to Fig6.					
3-3	REFLOW CONDITIONS (REFERENCE)	Refer to Fig7.					
3-4	LAND PATTERN (REFERENCE)	Refer to Fig8.					
4. Envir	conmental and mechanical performance shall be	specified by attached general specification.					
Th	OF FREON: his related product is not used with any ODC CL						
	X321G TYPE SURFACE MOUNT TYPE JARTZ CRYSTAL SPECIFICATION	Remark					
Date	2008/12/08	Spec. No. Rev. Page 1B326000AB0AR 1C326000AB0AR 1 / 7 1N326000AB0AR 1 / 7					

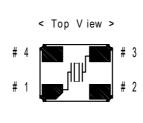












It is recommended that #2,4 is connected with GND.

unit : mm

Tolerance : ±-0.1

(Fig.-1)

Marking is Laser Marking:

Marking should be printed as follows:

Logo, Nominal Frequency, manufactured year & month

Logo(1), Nominal Frequency (2) and manufacturing location

Producing District	Our Specification.No.	(1) Logo	(2) Frequency
Japan	1B326000AB0AR	D	26
Indonesia	1C326000AB0AR	<u>D</u>	26

Nominal Frequency (2) = Mark two digits from upper

(ex. 26.000000 MHz --> 26)

Manufacturing lot No.(3)

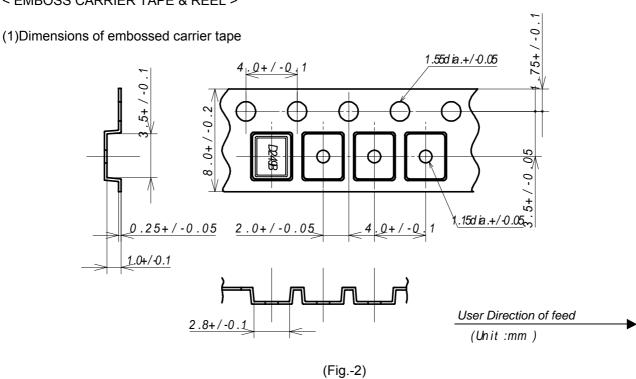
(year) ex. 2008 shall be marked as '8 ' (The last digit of the year) (Month) ex. December shall be marked as ' M ' (As shown in Table-1.)

(Table-1)

		(100.0	• /								
Jan.	Feb.	Mar.	Apr.	May.	Jun.	Jul.	Aug.	Sep.	Oct.	Nov.	Dec.
Α	B	C	D	F	F	G	Н	.1	K	ı	M

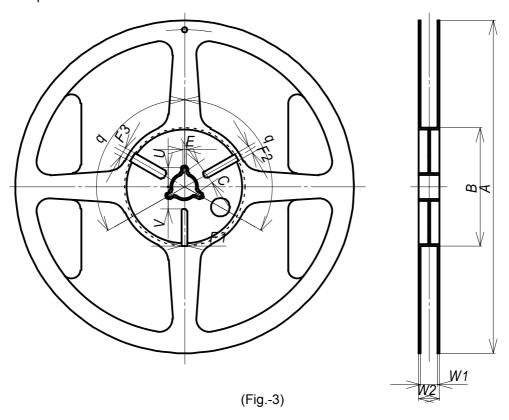
TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
	1B326000AB0AR		
2008/12/08	1C326000AB0AR		
	1N326000AB0AR		2 / 7

< EMBOSS CARRIER TAPE & REEL >



Pin No.1 is located on the sprocket-hole side of the tape.

(2)Dimensions of tape reel



TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		3 / 7

(Table-2)

(UNIT:mm)

	Item		Mark	Dimensions Angle
	Diameter	ſ	Α	180 Ф +0.0 / -3.0
Flange	Inside of Fra	nge	W1	9.0 ± 0.3
Flarige	Outside of Fra	ange	W2	11.4 ± 1.0
	Inside Diam	eter	В	60 Ф +1.0 / -0.0
			F1	3.0 ± 0.2
	Center Core Slit	Width	F2	4.0 ± 0.2
			F3	5.0 ± 0.2
Center		Length	V	11.9 +0.5 / -0.0
Core		Angle	q	120°
	Spindle Dian	neter	С	13 Φ ± 0.2
		Width	Е	2.0 ± 0.5
	Key Seats	Length	U	10.5 ± 0.4
		Angle	q	120°

(3)Storage condition

Temperature : +40 °C max. Relative Humidity : 80% max.

(It is a guaranteed term because it obtains an excellent soldering: 6 months)

(4)Standard packing quantity 3,000 pcs./reel for 180 Φ

(5)Material of the tape

Tape	Material
Carrier tape	Polystyrene+Carbon
Cover tape	Polyester

(6)Label contents

Type

Our specification No.

Your Part No.

Lot No.

Nominal Frequency

Quantity

Our Company Name

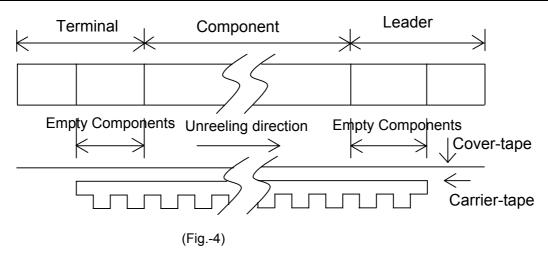
Producting Country

Stick a label on the each reel.

TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		4 / 7

(7)Taping dimension

Leader	Cover-tape	The length of cover-tape in the leader is more than 400mm
		including empty embossed area.
	Carrier-tape	After all products were packaged, must remain more than
		twenty pieces or 400mm empty area, which should be sealed
		by cover-tape.
Terminal	Cover-tape	The tip of cover-tape shall be fixed temporary by paper
		tape and roll around the core of reel one round.
	Carrier-tape	The empty embossed area which are sealed by cover-tape
		must remain more than 40mm.



(8) Joint of tape

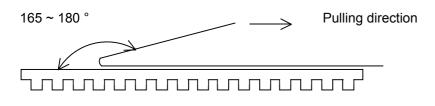
The carrier-tape and cover-tape should not be jointed.

(9)Release strength of cover tape

It has to between $0.1 \sim 0.7N$ under following condition.

Pulling direction $165 \sim 180^{\circ}$ Speed 300mm/min.

Otherwise unless specified.



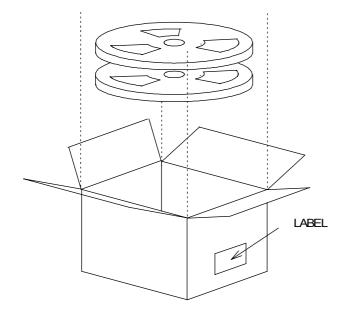
(Fig.-5)

Other standards shall be based on JIS C 0806₋₁₉₉₀

TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		5 / 7

< PACKING >

(1)STORAGE METHOD



Label contents

The type of product Lot No. Specification Quantity Shipment Day Remark

(Fig-6)

(2)BOX SIZE

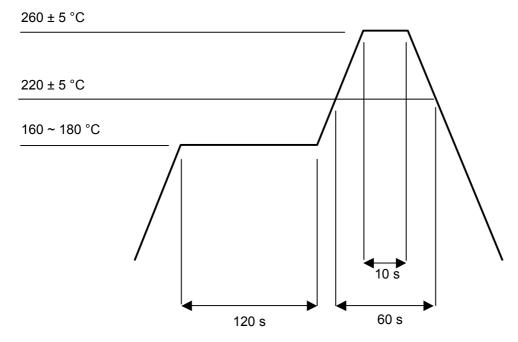
From lot size packingsize shall be changed.

In the upper and lower part and the opening in box it shall be protected products using aircushion sheets.

TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		6 / 7

< REFLOW CONDITIONS (REFERENCE) >

During the solder reflow process, please complete within following temperature, period. Reflow soldering shall be allowed only 3 times.

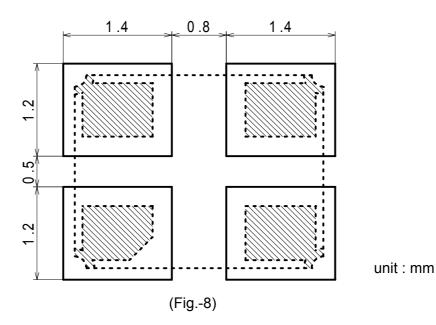


Total time: 200 s max.

(Fig.-7)

HANDSOLDERING METHOD : 350 ± 10 °C , 3+1/-0s Each terminal once (Please take care so that a soldering iron should not touch a product directly.)

< LAND PATTERN (REFERENCE) >



1.MECHANICAL ENDURANCE

1.1 SHOCK (ACCELERATION)

After the following test, parts shall conform specification 3-1-1. 1000m/s² by 6ms X,Y,Z each axis (6 directions), 3cycles

1.2 SHOCK (MOUNTING DROP)

After the following test, parts shall conform specification 3-1-1.

3cycles(18times) drop from 150 cm heights to concrete.

Further, parts shall be solderd on substrate, fixed Aluminum materials (about 100g).

Substrate materials : Glass Epoxy

1 cycle : each 1 times of 6 directions

1.3 VIBRATION

After the following test, parts shall conform specification 3-1-1.

and no abnormal appearance shall be observed.

Frequency of Vibration : $10 \sim 500 \sim 10 \text{ Hz}$

Amplitude(p-p) : Sine waves of 1.5mm or 100m/s^2

Cycle : 11min Vibration axis : X.Y.Z

Vibration period : 2 h for each axis

1.4 SEAL

Less than 2.0×10⁻⁹ Pa m³/s. by Helium leak detector.

Also, no serial bubble is observed by Fluorocarbon tests.

1.5 SOLDERABILITY

After the following test, more than 95% of terminal shall be covered by new solder.

 3 ± 0.5 s dip in 245 \pm 5 °C solder.

(Solder composition: Sn-3Ag-0.5Cu) (Use rosin type flux for solder.)

1.6 RESISTANCE TO SOLDERING HEAT (REFLOW)

48 h past at room temperature from following test, parts

shall conform specification 3-1-2.

perform the attached Reflow conditions to reference.

1.7 RESISTANCE TO SOLDERING HEAT (HAND SOLDERING METHOD)

48 h past at room temperature from following test, parts

shall conform specification 3-1-2.

 $350 \pm 10^{\circ}$ C, 3+1/-0s Each terminal once

1.8 SUBSTRATE BENDING

After the following test, parts shall conform specification 3-1-1.

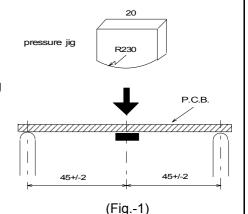
and no abnormality shall be observed in external appearance and sealing tightnen and others shall be based on ET-7403 of EIAJ.

Mount the specimen on substrate.

Apply the following pressure

Direction : see Fig.-1 Speed : about 1.0 mm/s

Hours : $5 \pm 1 \text{ s}$ Amount of substrate : 3 mm max.



TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		Attached sheet 1 / 4

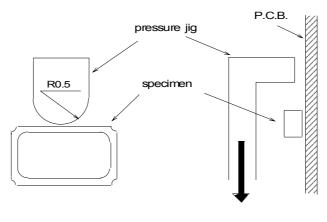
1.9 SHEAR

After the following test,parts shall conform specification 3-1-1. and no abnormality shall be observed in external appearance and sealing tightness and others shall be based on ET-7403 of EIAJ.

Mount the specimen on substrate.

Apply the following pressure

Weight : 10 NHours : $10 \pm 1 \text{ s}$ Direction : see Fig.-2



(Fig.-2)

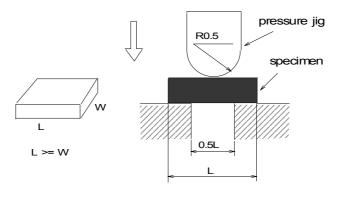
1.10 BODY STRENGTH

After the following test,parts shall conform specification 3-1-1. and no abnormality shall be observed in external appearance and sealing tightness and others shall be based on ET-7403 of EIAJ.

Mount the specimen on substrate.

Apply the following pressure

Weight : 10 NHours : $10 \pm 1 \text{ s}$ Direction : see Fig.-3



(Fig.-3)

TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE QUARTZ CRYSTAL SPECIFICATION	remark		
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		Attached sheet 2 / 4

2.ENVIRONMENTAL ENDURANCE

2.1 LOW TEMPERATURE

2 h past at room temperature after following test, parts shall conform specification 3-1-1. 240 h -40 \pm 3 °C.

2.2 HUMIDITY

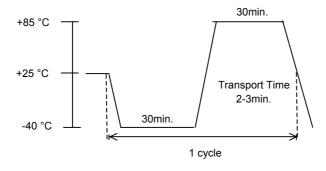
2 h past at room temperature after following test, parts shall conform specification 3-1-1. 240 h +85 \pm 2 °C , relative humidity 85 \pm 5%.

2.3 HIGH TEMPERATURE

2 h past at room temperature after following test, parts shall conform specification 3-1-1. 240 h +85 \pm 2 °C.

2.4 TEMPERATURE CYCLE

2 h past at room temperature after 25 cycles of following test, parts shall conform specification 3-1-1.



(Fig.-4)

3.SPECIFICATION

Frequency Variation and Equivalent Resistance shall be within Table-1 after the test.

(Table-1)

	Frequency Variation Equivalent Resistance		
3-1-1	±2 ppm	±15 % or 2 Ω max. (Use larger specification)	
3-1-2	±5 ppm	±20 % or 3 Ω max. (Use larger specification)	
3-1-3	±10 ppm	±20 % or 3 Ω max. (Use larger specification)	

TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		Attached sheet 3 / 4

[DSX321G SERIES , IN USE]

1.SOLDERING

Please perform the attached Reflow conditions to reference within 3 times.

2.MOUNT

Crystal products are designed to be compatible with automatic mounting. Be sure to have a mounting test in advance by using the actual mounting machine and check that the characteristics of the products are not damaged by the automatic mounting.

In the process where the boad is warped, such as board separation process, be careful that the warping does not influence the characteristics and soldering of crystal products.

Since mounting by Ultrasonic welding and processing have a possibility of an excessive vibration spreading inside a crystal resonator and becoming the cause of characteristic deterioration and not oscillating, it does not recommend.

3.WASHING

About use of the washing liquid of a basin system, an alcoholic system, and a chlorofluorocarbon-replacing material system, it is checking that it is satisfactory. However please consult in advance about other washing liquid. Although the check about ultrasonic washing is performed, since it is an examination with a simple substance, the check for the second time by the use state is recommended.

4.THE CAUTIONS ON USE

The piece of crystal it is processed very smaller than the conventional thing inside DSX321G series crystal unit may be damaged,

if excessive excitation electric power is applied.

Please use it below with the value specified on a catalog and specifications.

Please refrain from forming patterns under crystal resonators since there is a possibility to cause crack in base.

If the temperature is higher than 280 °C, there is a possibility for the sealing glass to remelt.

Avoid using the product at temperature higher than specified.

5.HANDLING OF A PRODUCT

DSX321G series has sufficient intensity to fall and vibration.

However when too much shock is added according to a certain cause,

the use after a characteristic check is recommended.

6.STORAGE

Since the soldering nature of a terminal may be degraded, please avoid storage in high temperature and a humid place. Please keep it in the place which direct rays do not hit and dew condensation does not generate.

TITLE	Remark		
DSX321G TYPE SURFACE MOUNT TYPE			
QUARTZ CRYSTAL SPECIFICATION			
Date	Spec. No.	Rev.	Page
2008/12/08	1B326000AB0AR 1C326000AB0AR 1N326000AB0AR		Attached sheet 4 / 4

2008-1640 REVISION RECORD

Rev.No	Date	Reason	Contents	Approved	Checked	Drawn
-	2008/12/08		The first edition.	T. Miura	H. Matsuda	M.Shikai

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Crystals category:

Click to view products by KDS manufacturer:

Other Similar products are found below:

CX3225GB25000M0PPSZ1 718-13.2-1 MC405 32.0000K-R3:PURE SN 7A-40.000MAAE-T FL2000085 99-BU 9B-15.360MBBK-B 9C-7.680MBBK-T H10S-12.000-18-EXT-TR ABC2-6.000MHZ-D4Z-T ABLS-20.000MHZ-D2-T ABS071-32.768KHZ-6-T R38-32.768-12.5-5PPM-NPB BTD1062E05A-513 21U15A-21.4MHZ RTX-781DF1-S-20.950 LFXTAL066198Cutt 9C-14.31818MBBK-T A-11.000MHZ-27 ABL-27.000MHZ-B4Y-T ABM11-132-24.000MHZ-T3 ABM3B1-25.000MHZ-D2Y-T SPT2A-.032768B SPT2A.032768G SSPT7F-9PF20-R FX325BS-38.88EEM1201 LFXTAL065253Cutt LFXTAL066431Cutt XT9S20ANA14M7456 XT9SNLANA16M 646G-24-2 7A-24.576MBBK-T 7B-30.000MBBK-T 7A-14.31818MBBK-T 6504-202-1501 6526-202-1501 ABLS-12.000MHZ-B2Y-T ABLS-10.000MHZ-D3W-T 7A-10.000MBBK-T SG636PCE-20.000MC 3404 E1SAA18-25.000M TR CM315D32768EZFT C1E-24.000-7-2020-R C1E-19.200-12-1530-X-R C1E-16.000-12-1530-X-R FL5000014 EUCA18-3.1872M FX0800015 425F35E027M0000